

<b>Search Notes</b> 	<b>Application/Control No.</b>	<b>Applicant(s)/Patent under Reexamination</b>
	10/664,404	SHEN ET AL.
	<b>Examiner</b>	<b>Art Unit</b>
	Minh Trinh	3729

# SEARCHED

Class	Subclass	Date	Examiner
29	600, 602.1, 25.35- 25.42, 610.1	10/26/2006	MT
	622, 825,		
336	232, 223,		
	200, 365		
257	686, 777		
	434, 704		
73	514.16,		
	514.36+		
310	309, 311		
156	250, 292		
438	52	✓	✓

<b>INTERFERENCE SEARCHED</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>